

**AO7405**
**P-Channel Enhancement Mode Field Effect Transistor**

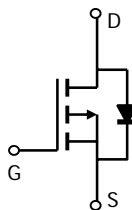
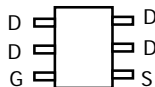
**General Description**

The AO7405 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge, and operation with gate voltages as low as 2.5V, in the small SOT363 footprint. It can be used for a wide variety of applications, including load switching, low current inverters and low current DC-DC converters. *Standard Product AO7405 is Pb-free (meets ROHS & Sony 259 specifications). AO7405L is a Green Product ordering option. AO7405 and AO7405L are electrically identical.*

**Features**

$V_{DS} (V) = -30V$   
 $I_D = -1.6A$  ( $V_{GS} = -10V$ )  
 $R_{DS(ON)} < 150m\Omega$  ( $V_{GS} = -10V$ )  
 $R_{DS(ON)} < 200m\Omega$  ( $V_{GS} = -4.5V$ )  
 $R_{DS(ON)} < 280m\Omega$  ( $V_{GS} = -2.5V$ )

SC-70-6  
 (SOT-363)  
 Top View


**Absolute Maximum Ratings**  $T_A=25^\circ C$  unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	V
Continuous Drain Current <sup>A</sup>	$I_D$	-1.6	A
$T_A=25^\circ C$			
$T_A=70^\circ C$		-1.3	
Pulsed Drain Current <sup>B</sup>	$I_{DM}$	-10	
Power Dissipation <sup>A</sup>	$P_D$	0.625	W
$T_A=25^\circ C$			
$T_A=70^\circ C$		0.4	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	$^\circ C$

**Thermal Characteristics**

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	160	200	$^\circ C/W$
$t \leq 10s$				
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	180	220	$^\circ C/W$
Steady-State				
Maximum Junction-to-Lead <sup>C</sup>	$R_{\theta JL}$	130	160	$^\circ C/W$
Steady-State				

Electrical Characteristics ( $T_J=25^{\circ}\text{C}$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D=-250\mu\text{A}$ , $V_{GS}=0\text{V}$	-30			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=-24\text{V}$ , $V_{GS}=0\text{V}$ $T_J=55^{\circ}\text{C}$			-1 -5	$\mu\text{A}$
$I_{GSS}$	Gate-Body leakage current	$V_{DS}=0\text{V}$ , $V_{GS}=\pm 12\text{V}$			$\pm 100$	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_D=-250\mu\text{A}$	-0.6	-1	-1.4	V
$I_{D(ON)}$	On state drain current	$V_{GS}=-4.5\text{V}$ , $V_{DS}=-5\text{V}$	-10			A
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=-10\text{V}$ , $I_D=-1.6\text{A}$ $T_J=125^{\circ}\text{C}$		115 195	150 240	$\text{m}\Omega$
		$V_{GS}=-4.5\text{V}$ , $I_D=-1\text{A}$		135	200	$\text{m}\Omega$
		$V_{GS}=-2.5\text{V}$ , $I_D=-1\text{A}$		190	280	$\text{m}\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS}=-5\text{V}$ , $I_D=-1.6\text{A}$	3	4		S
$V_{SD}$	Diode Forward Voltage	$I_S=-1\text{A}$ , $V_{GS}=0\text{V}$		-0.85	-1	V
$I_S$	Maximum Body-Diode Continuous Current				-0.5	A
<b>DYNAMIC PARAMETERS</b>						
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}$ , $V_{DS}=-15\text{V}$ , $f=1\text{MHz}$		409		pF
$C_{oss}$	Output Capacitance			55		pF
$C_{rss}$	Reverse Transfer Capacitance			42		pF
$R_g$	Gate resistance	$V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$		12		$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g$	Total Gate Charge	$V_{GS}=-4.5\text{V}$ , $V_{DS}=-15\text{V}$ , $I_D=-1\text{A}$		5.06		nC
$Q_{gs}$	Gate Source Charge			0.72		nC
$Q_{gd}$	Gate Drain Charge			1.58		nC
$t_{D(on)}$	Turn-On DelayTime	$V_{GS}=-10\text{V}$ , $V_{DS}=-15\text{V}$ , $R_L=15\Omega$ , $R_{GEN}=3\Omega$		6.2		ns
$t_r$	Turn-On Rise Time			3.2		ns
$t_{D(off)}$	Turn-Off DelayTime			41.2		ns
$t_f$	Turn-Off Fall Time			14.5		ns
$t_{rr}$	Body Diode Reverse Recovery Time	$I_F=-1\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$		13.2		ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F=-1\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$		5.4		nC

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ . The value in any given application depends on the user's specific board design. The current rating is based on the  $t \leq 10\text{s}$  thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D: The static characteristics in Figures 1 to 6, 12, 14 are obtained using 80 $\mu\text{s}$  pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ . The SOA curve provides a single pulse rating.

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

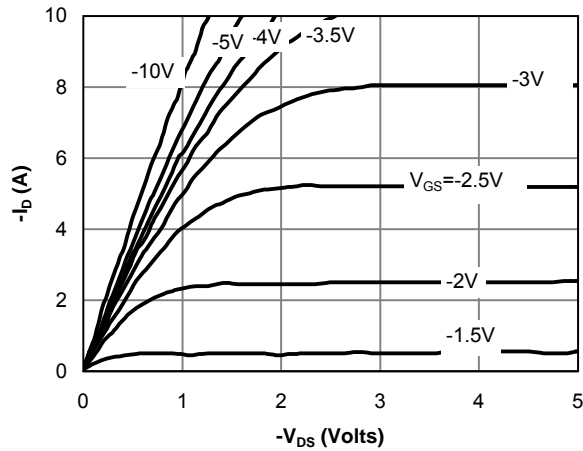


Fig 1: On-Region Characteristics

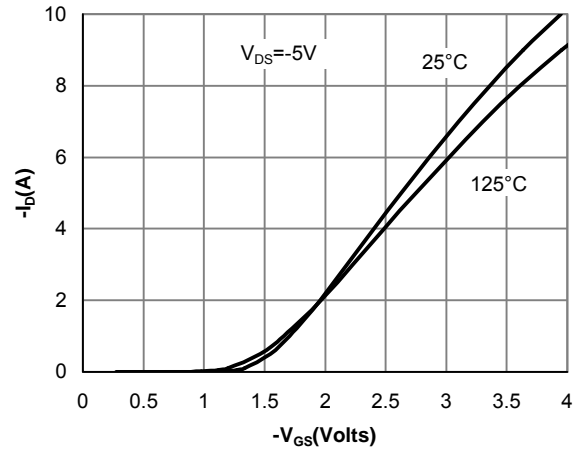


Figure 2: Transfer Characteristics

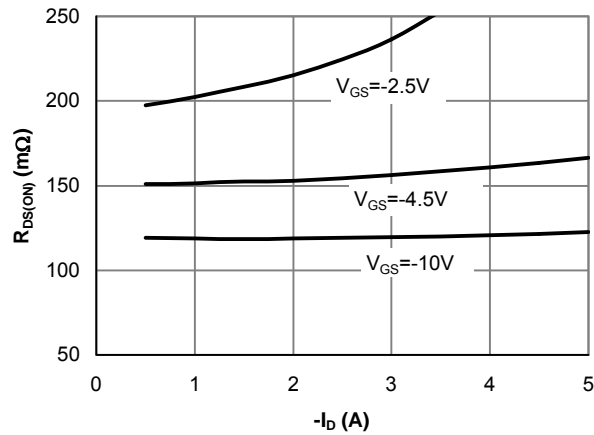


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

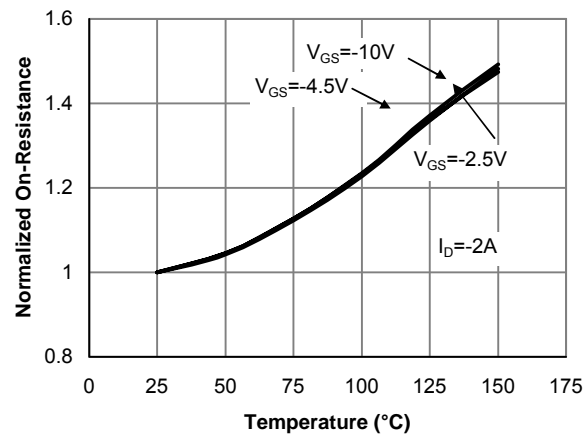


Figure 4: On-Resistance vs. Junction Temperature

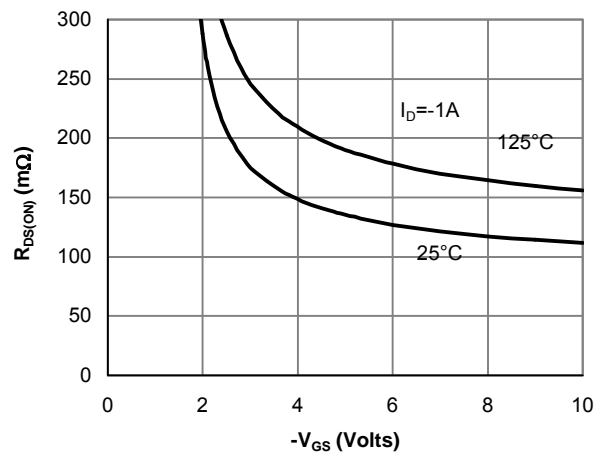


Figure 5: On-Resistance vs. Gate-Source Voltage

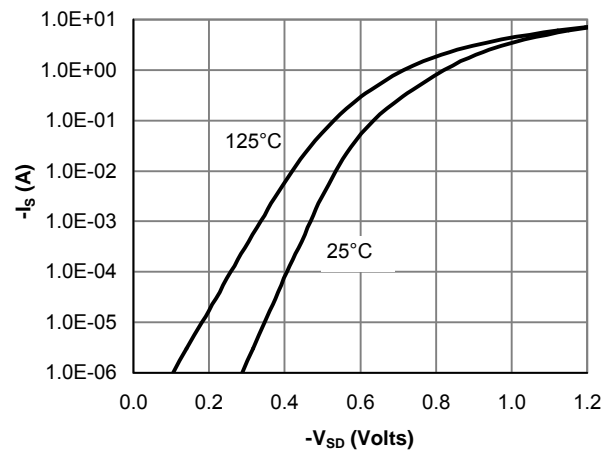


Figure 6: Body-Diode Characteristics

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